

EITP25 – General information

LAST UPDATED 24 March





Course information

<u>Aim</u>

The purpose of this course is to give an in depth understanding for the physics of common memory device technologies with focus on nonvolatile memories. Furthermore, the course covers how these memory devices can be integrated to create neuromorphic hardware for applications in machine learning and artificial intelligence. Finally, course gives an introduction to the architectures and algorithms that are used in machine learning, to give a basic understanding for the needs that memory devices and their connections need to fulfil.

Course responsible

Mattias Borg

Assistant Professor Nanoelectronics

Research

Nanomaterials integration, Ferroelectric and RRAM devices, Neuromorphic devices and systems

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Syllabus

Lecture modules

F1-F2.

Introduction to memory technologies

F3-F4.

Machine Learning Fundamentals

F5-F7.

Neuromorphic computing

F8-F12.

Emerging memory technologies

F13-F14.

Neuromorphic Hardware in Reality

Lab exercise

1.0 hp.
Measurement
and analysis of

RRAM

Hand-in assignment (elective)

Block 1

Block 2

Block 3

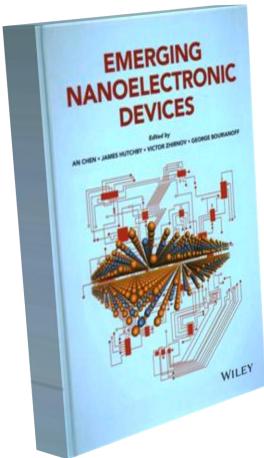
Group Project

2.5 hp. Simulation of Spiking Neural Net for image classification

Examination

4.0 hp Written exam

Course material



Chen, Hutchby, Zhirnov and Bourianoff

- Many lectures are based on Chen et al.
 - L2, L5, L8, L9, L10, L14
- In addition, many research papers
 - Links (will be) available on Canvas
 - Refer to references on slides
- Additional learning material
 - Blogs, videos

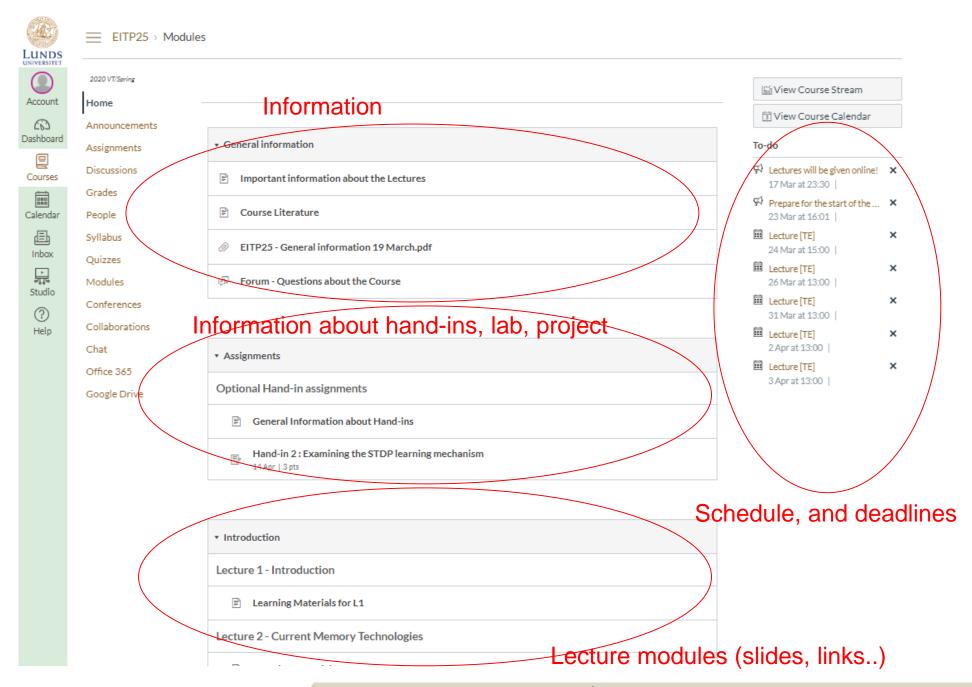


Suri

We use just a bit, and there are options

Canvas

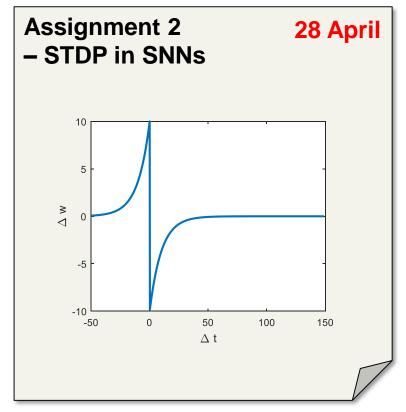
canvas.education.lu.se

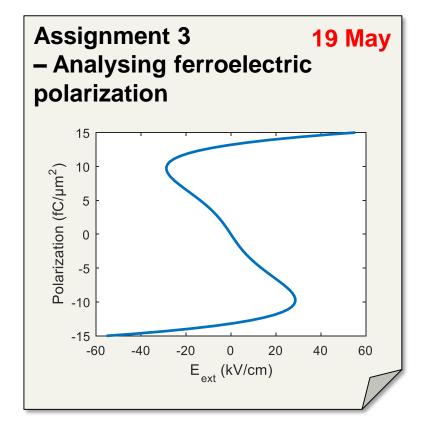


Hand-in assignments

- 3 assignments, each can give 3 points on the exam (max 9)
 - BUT, full points requires excellent work and nice report
- Each assignment is available for 1 week before the deadline

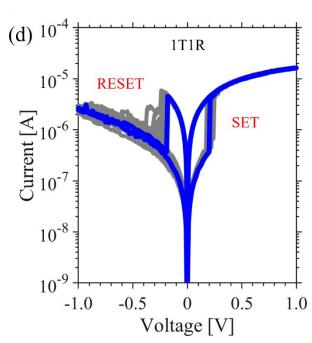


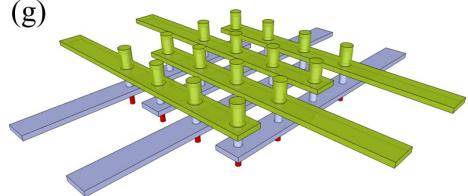


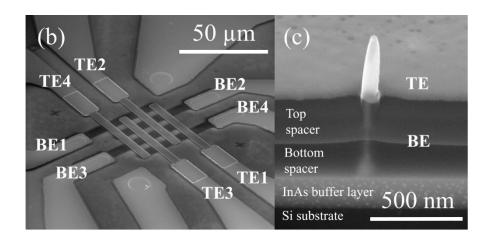


Lab exercise

- Electrical characterization of HfO₂/ITO RRAM devices integrated on vertical nanowires
- Analysis of measurement data
- Groups of <u>four students</u>
- When: Scheduled 29 April 8-12
 - Planned: 2h measurement session
 - Alternative: Virtual demonstration over Zoom
- Analysis and Lab report:
 - Performed per group
 - Submit report through Canvas



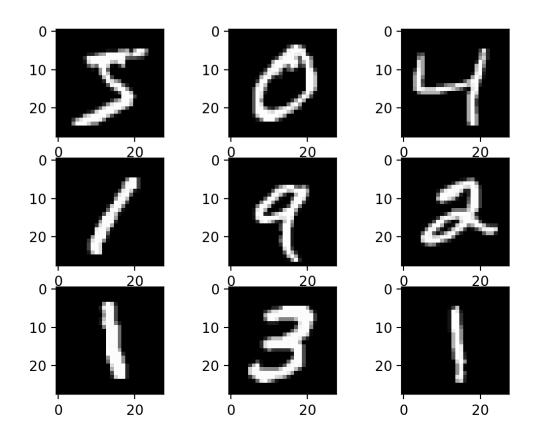




Group Project

- Groups of <u>up to four</u> students
- Task: Build spiking neural network to perform image classification
- Software to use: BRIAN2 python library
 - https://brian2.readthedocs.io/en/stable/
- Project will start 27 April
 - More details as the time draws near
- Examination:
 - Report and source code
 - Deadline 31 May

MNIST data set



Examination

- Exam is planned for 4 June 14-18
- Current plan is for regular examination, this may change...
 - Update: Probably <u>home exam</u>
- "Will this be on the exam?"
 - Anything that we bring up on Lectures/Lab may come...
 - Refer to lecture slides/notes.

